

Supporting Information for

Fluoropolymer-Containing Opals and Inverse Opals by Melt-Shear Organization

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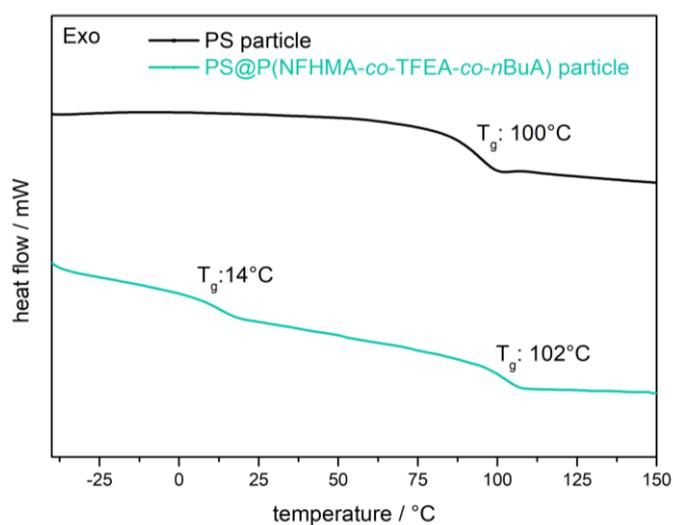


Figure S1: Differential Scanning Calorimetry (DSC) thermograms of PS@P(NFHMA-co-TFEA-co-nBuA) precipitated core/interlayer/shell particles (green) with two glass transition temperatures at 14 °C and 102 °C and of PS core particles (black) with the glass transition temperature of 100°C.

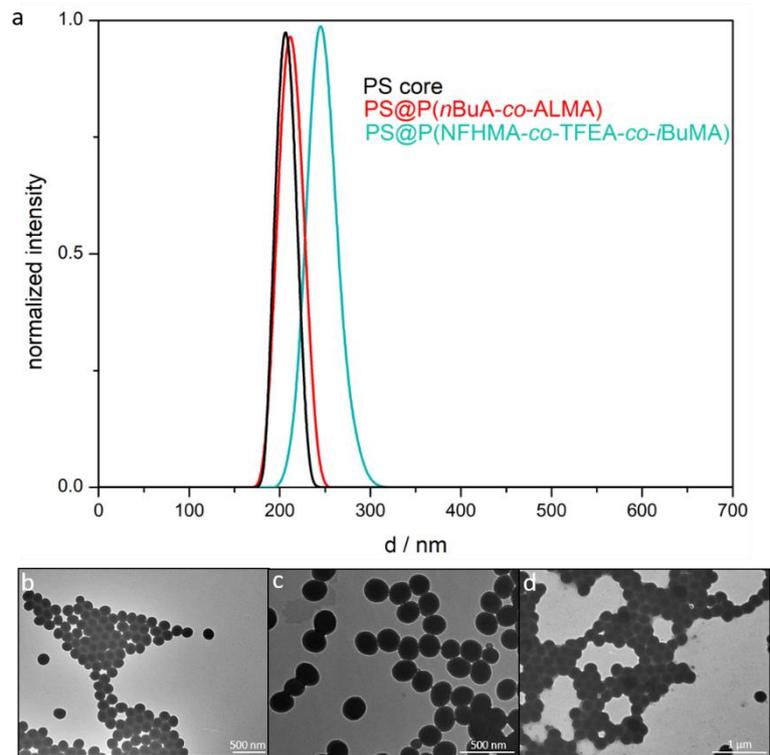


Figure S2: a) DLS investigations after each stage of stepwise emulsion polymerization to determine the hydrodynamic diameter and size distribution of the PS@P(NFHMA-*co*-TFEA-*co*-*n*BuA) particles; b) TEM images of PS cores; c) TEM image of the core/interlayer particles; d) TEM image of the core/interlayer/shell particles PS@P(NFHMA-*co*-TFEA-*co*-*n*BuA).

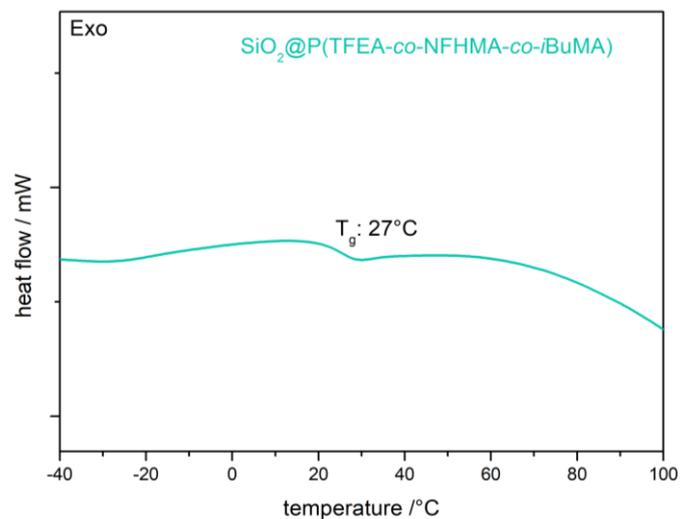


Figure S3: Differential Scanning Calorimetry (DSC) thermogram of SiO₂@P(TFEA-*co*-NFHMA-*co*-*i*BuMA) precipitated core/interlayer/shell particles with a glass transition temperature of 27° C.

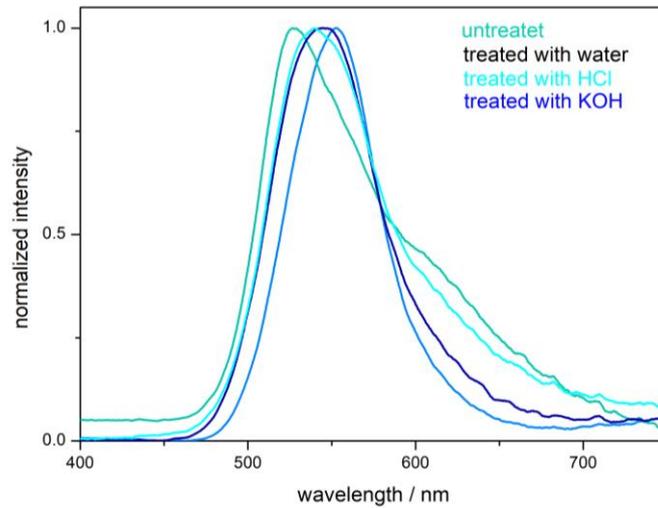


Figure S4: UV/-Vis spectra of the PS@P(NFHMA-*co*-TFEA-*co*-*n*BuA) opal film, untreated and treated with water, potassium hydroxide and hydrochloric acid. The reflection peak maxima untreated is located at a wavelength of 525 nm, treated with water at 544 nm, with potassium hydroxide (pH=13) 550 nm and hydrochloric acid (pH=1) at 540 nm.

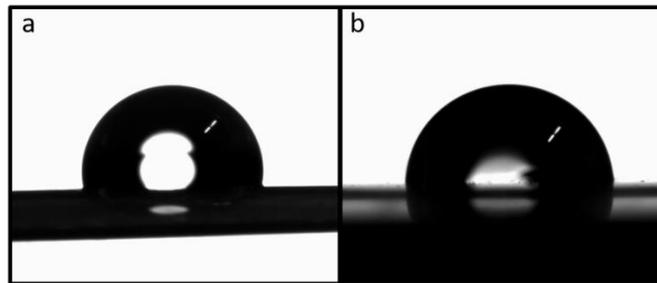


Figure S5: a) Photograph of a drop of water (2 μ l) on the PS@P(NFHMA-*co*-TFEA-*co*-*n*BuA) opal film with a contact angle of $106^\circ \pm 3^\circ$; b) photograph of a drop of water (2 μ l) on the SiO₂@P(NFHMA-*co*-TFEA-*co*-*n*BuA) inverse opal film with a contact angle of $102^\circ \pm 2^\circ$.

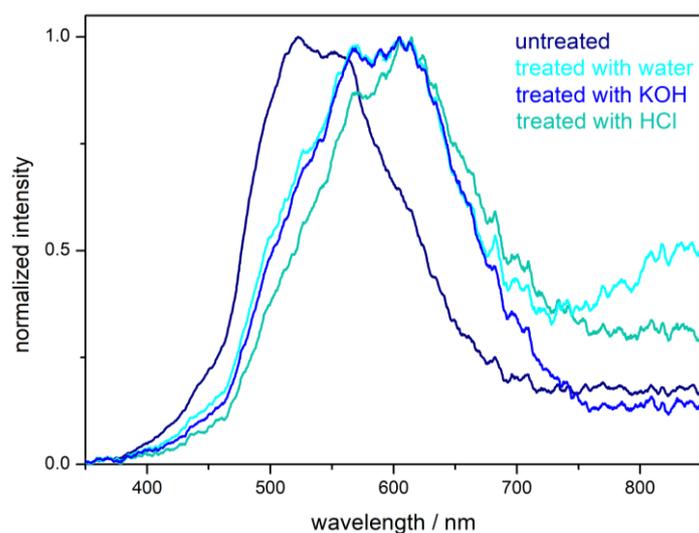


Figure S6: UV/-Vis spectra of the SiO₂@P(TFEA-co-NFHMA-co-iBuMA) opal film, untreated and treated with water, potassium hydroxide and hydrochloric acid. The reflection peak maxima untreated is located at a wavelength of 518 nm, treated with water at 570 nm, with potassium hydroxide (pH=13) 570 nm and hydrochloric acid (pH=1) at 574 nm.